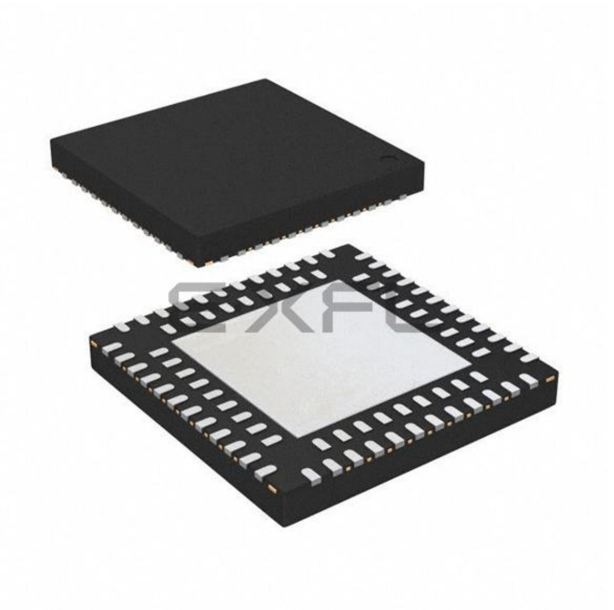

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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	160
Number of Logic Elements/Cells	1280
Total RAM Bits	65536
Number of I/O	67
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	84-VFQFN Dual Rows, Exposed Pad
Supplier Device Package	84-QFN (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/ice65l01f-lqn84c

Packaging Options

iCE65 components are available in a variety of package options to support specific application requirements. The available options, including the number of available user-programmable I/O pins (PIOs), are listed in Table 2. Fully-tested Known-Good Die (KGD) DiePlus™ are available for die stacking and highly space-conscious applications. All iCE65 devices are provided exclusively in Pb-free, RoHS-compliant packages.

***Table 2:* iCE65 Family Packaging Options, Maximum I/O per Package**

Package	Package Body (mm)	Package Code	Ball/Lead Pitch (mm)	65L01	65L04	65L08
81-ball chip-scale BGA	5 x 5	CB81	0.5	63 *(0)*	—	—
84-pin quad flat no-lead package	7 x 7	QN84	0.5	67 *(0)*	—	—
100-pin very thin quad flat package	14 x 14	VQ100	0.5	72 *(0)* ⟺	72 *(9)*	—
121-ball chip-scale BGA	6 x 6	CB121	0.5	92 *(0)*	—	—
132-ball chip-scale BGA	8 x 8	CB132	0.5	93 *(0)* ⟺	95 *(11)* ⟺	95 *(12)*
196-ball chip-scale BGA	8 x 8	CB196	0.5	—	150 *(18)* ⟺	150 *(18)*
284-ball chip-scale BGA	12 x 12	CB284	0.5	—	176 *(20)* ⟺	222 *(25)*
Known Good Die	See DiePlus data sheet	DI	—	95 *(0)*	176 *(20)*	222 *(25)*

⟺ = Common footprint allows each density migration on the same printed circuit board. *(Differential input count)*.

The iCE65L04 and the iCE65L08 are both available in the CB196 package and have similar footprints but are not completely pin compatible. See "Pinout Differences between iCE65L04 and iCE65L08 in CB196 Package" on page 73 for more information.

When iCE65 components are supplied in the same package style, devices of different gate densities share a common footprint. The common footprint improves manufacturing flexibility. Different models of the same product can share a common circuit board. Feature-rich versions of the end application mount a larger iCE65 device on the circuit board. Low-end versions mount a smaller iCE65 device.

Look-Up Table (LUT4)

The four-input Look-Up Table (LUT4) function implements any and all combinational logic functions, regardless of complexity, of between zero and four inputs. Zero-input functions include "High" (1) and "Low" (0). The LUT4 function has four inputs, labeled I0, I1, I2, and I3. Three of the four inputs are shared with the Carry Logic function, as shown in Figure 4. The bottom-most LUT4 input connects either to the I3 input or to the Carry Logic output from the previous Logic Cell.

The output from the LUT4 function connects to the flip-flop within the same Logic Cell. The LUT4 output or the flip-flop output then connects to the programmable interconnect.

For detailed LUT4 internal timing, see Table 54.

'D'-style Flip-Flop (DFF)

The 'D'-style flip-flop (DFF) optionally stores state information for the application.

The flip-flop has a data input, 'D', and a data output, 'Q'. Additionally, each flip-flop has up to three control signals that are shared among all flip-flops in all Logic Cells within the PLB, as shown in Figure 4. Table 3 describes the behavior of the flip-flop based on inputs and upon the specific DFF design primitive used or synthesized.

Table 3: 'D'-Style Flip-Flop Behavior

DFF Primitive	Operation	Flip-Flop Mode	Inputs				Output
			D	**EN**	**SR**	**CLK**	**Q**
All	Cleared Immediately after Configuration	X	X	X	X	X	0
	Hold Present Value (Disabled)		X	0	X	X	Q
	Hold Present Value (Static Clock)		X	X	X	1 or 0	Q
	Load with Input Data		D	1*	0*	↑	D
SB_DFFR	Asynchronous Reset	Asynchronous Reset	X	X	1	X	0
SB_DFFS	Asynchronous Set	Asynchronous Set	X	X	1	X	1
SB_DFFSR	Synchronous Reset	Synchronous Reset	X	1*	1	↑	0
SB_DFFSS	Synchronous Set	Synchronous Set	X	1*	1	↑	1

X = don't care, ↑ = rising clock edge (default polarity), 1* = High or unused, 0* = Low or unused

The CLK clock signal is not optional and is shared among all flip-flops in a Programmable Logic Block. By default, flip-flops are clocked by the rising edge of the PLB clock input, although the clock polarity can be inverted for all the flip-flops in the PLB.

The CLK input optionally connects to one of the following clock sources.

- The output from any one of the eight Global Buffers, or
- A connection from the general-purpose interconnect fabric

The EN clock-enable signal is common to all Logic Cells in a Programmable Logic Block. If the enable signal is not used, then the flip-flop is always enabled. This condition is indicated as "1*" in Table 3. The asterisk indicates that this is the default state if the control signal is not connected in the application.

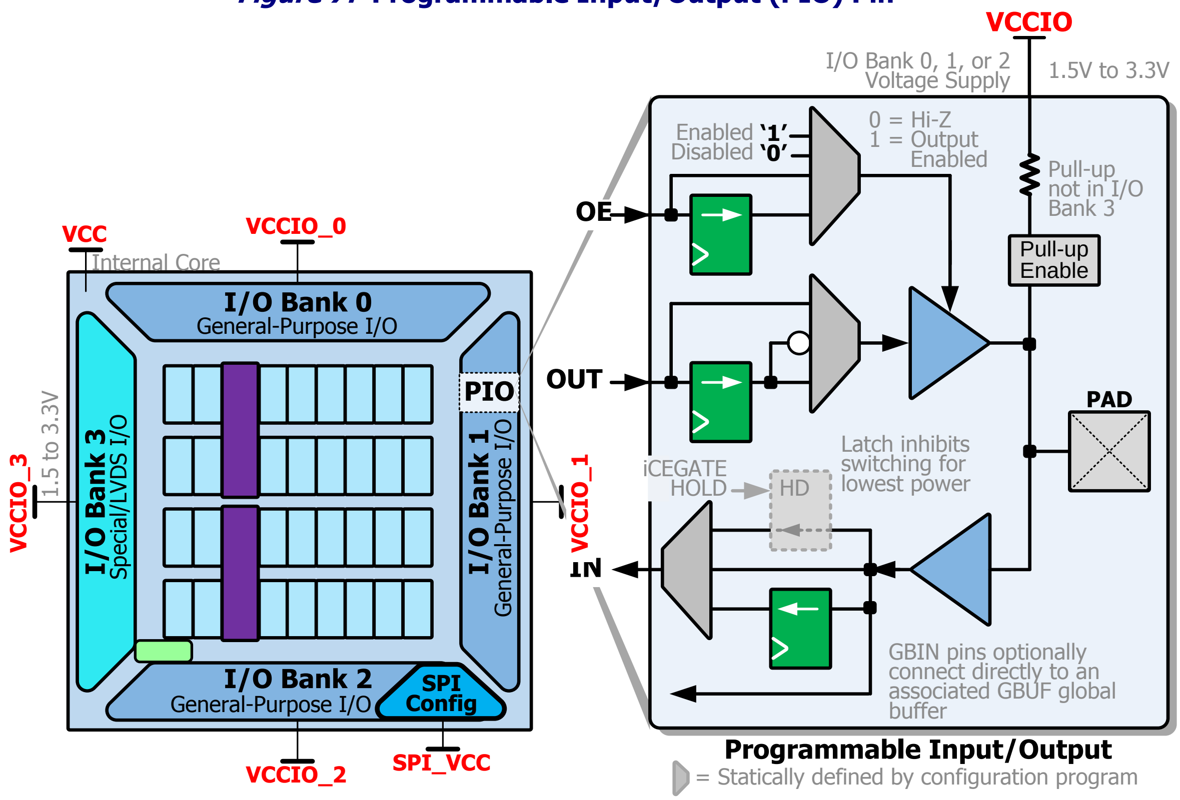
Similarly, the SR set/reset signal is common to all Logic Cells in a Programmable Logic Block. If not used, then the flip-flop is never set/reset, except when cleared immediately after configuration or by the Global Reset signal. This condition is indicated as "0*" in Table 3. The asterisk indicates that this is the default state if the control signal is not connected in the application.

Programmable Input/Output Block (PIO)

Programmable Input/Output (PIO) blocks surround the periphery of the device and connect external components to the Programmable Logic Blocks (PLBs) and RAM4K blocks via programmable interconnect. Individual PIO pins are grouped into one of four I/O banks, as shown in Figure 7. I/O Bank 3 has additional capabilities, including LVDS differential I/O and the ability to interface to Mobile DDR memories.

Figure 7 also shows the logic within a PIO pin. When used in an application, a PIO pin becomes a signal input, an output, or a bidirectional I/O pin with a separate direction control input.

Figure 7: Programmable Input/Output (PIO) Pin



I/O Banks

PIO blocks are organized into four separate I/O banks, each with its own voltage supply input, as shown in Table 5. The voltage applied to the VCCIO pin on a bank defines the I/O standard used within the bank. Table 50 and Table 51 describe the I/O drive capabilities and switching thresholds by I/O standard. On iCE65L04 and iCE65L08 devices, I/O Bank 3, along the left edge of the die, is different than the others and supports specialized I/O standards.

I/O Bank Voltage Supply Inputs Support Different I/O Standards

Because each I/O bank has its own voltage supply, iCE65 components become the ideal bridging device between different interface standards. For example, the iCE65 device allows a 1.8V-only processor to interface cleanly with a 3.3V bus interface. The iCE65 device replaces external voltage translators.

Table 5: Supported Voltages by I/O Bank

Bank	Device Edge	Supply Input	3.3V	2.5V	1.8V	1.5V
0	Top	VCCIO_0	Yes	Yes	Yes	Outputs only
1	Right	VCCIO_1	Yes	Yes	Yes	Outputs only
2	Bottom	VCCIO_2	Yes	Yes	Yes	Outputs only
3	Left	VCCIO_3	Yes	Yes	Yes	iCE65L01: Outputs only iCE65L04/08: Yes
SPI	Bottom Right	SPI_VCC	Yes	Yes	Yes	No

If not connected to an external SPI PROM, the four pins associated with the SPI Master Configuration Interface can be used as PIO pins, supplied by the SPI_VCC input, essentially forming a fifth "mini" I/O bank. If using an SPI Flash PROM, then connect SPI_VCC to 3.3V.

I/O Banks 0, 1, 2, SPI and Bank 3 of iCE65L01

Table 6 highlights the available I/O standards when using an iCE65 device, indicating the drive current options, and in which bank(s) the standard is supported. I/O Banks 0, 1, 2 and SPI interface support the same standards. I/O Bank 3 has additional capabilities in iCE65L04 and iCE65L08, including support for MDDR memory standards and LVDS differential I/O.

Table 6: **I/O Standards for I/O Banks 0, 1, 2, SPI Interface Bank, and Bank 3 of iCE65L01**

I/O Standard	Supply Voltage	Drive Current (mA)	Attribute Name
5V Input Tolerance	3.3V	N/A	N/A
LVCMOS33	3.3V	±11	SB_LVCMOS
LVCMOS25	2.5V	±8	
LVCMOS18	1.8V	±5	
LVCMOS15 outputs	1.5V	±4	

IBIS Models for I/O Banks 0, 1, 2 and the SPI Bank

The IBIS (I/O Buffer Information Specification) file that describes the output buffers used in I/O Banks 0, 1, 2, SPI Bank and Bank 3 of iCE65L01 is available from the following link.

- IBIS Models for I/O Banks 0, 1, 2, SPI Bank and Bank 3 of iCE65L01

I/O Bank 3 of iCE65L04 and iCE65L08

I/O Bank 3, located along the left edge of the die, has additional special I/O capabilities to support memory components and differential I/O signaling (LVDS). Table 7 lists the various I/O standards supported by I/O Bank 3. The SSTL2 and SSTL18 I/O standards require the VREF voltage reference input pin which is only available on the CB284 package. Also see Table 51 for electrical characteristics.

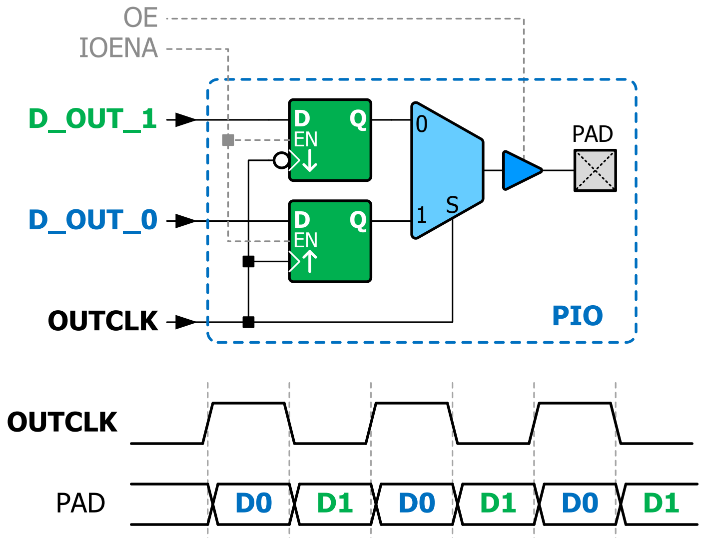
Table 7: **I/O Standards for I/O Bank 3 Only of iCE65L04 and iCE65L08**

I/O Standard	Supply Voltage	VREF Pin (CB284 or DiePlus) Required?	Target Drive Current (mA)	Attribute Name
LVCMOS33	3.3V	No	±8	SB_LVCMOS33_8
LVCMOS25	2.5V	No	±16	SB_LVCMOS25_16
			±12	SB_LVCMOS25_12
			±8	SB_LVCMOS25_8
			±4	SB_LVCMOS25_4
LVCMOS18	1.8V	No	±10	SB_LVCMOS18_10
			±8	SB_LVCMOS18_8
			±4	SB_LVCMOS18_4
			±2	SB_LVCMOS18_2
LVCMOS15	1.5V	No	±4	SB_LVCMOS15_4
			±2	SB_LVCMOS15_2
SSTL2_II	2.5V	Yes	±16.2	SB_SSTL2_CLASS_2
SSTL2_I			±8.1	SB_SSTL2_CLASS_1
SSTL18_II	1.8V	Yes	±13.4	SB_SSTL18_FULL
SSTL18_I			±6.7	SB_SSTL18_HALF
MDDR	1.8V	No	±10	SB_MDDR10
			±8	SB_MDDR8
			±4	SB_MDDR4
			±2	SB_MDDR2
LVDS	2.5V	No	N/A	SB_LVDS_INPUT

Double Data Rate (DDR) Flip-Flops

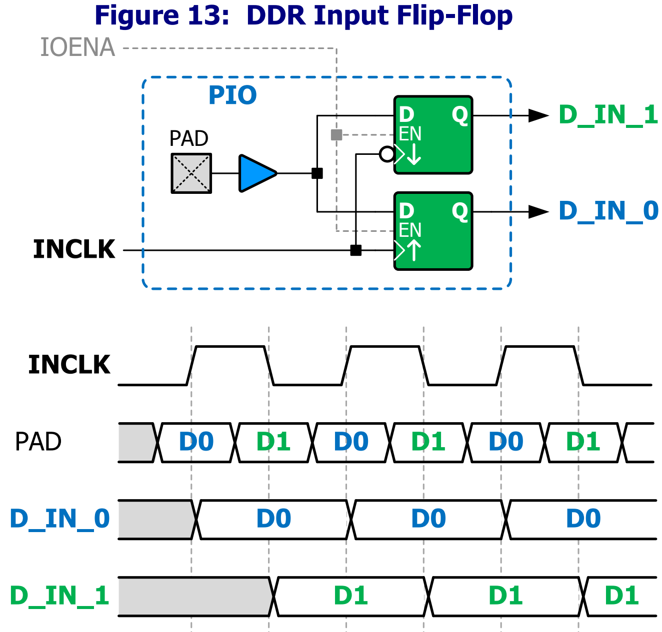
Each individual PIO pin optionally has two sets of double data rate (DDR) flip-flops; one input pair and one output pair. Figure 12 demonstrates the functionality of the output DDR flip-flop. Two signals from within the iCE65 device drive the DDR output flip-flop. The D_OUT_0 signal is clocked by the rising edge of the OUTCLK signal while the D_OUT_1 signal is clocked by the falling edge of the OUTCLK signal, assuming no optional clock polarity inversion. Internally, the two individual flip-flops are multiplexed together before the data appears at the pad, effectively doubling the output data rate.

Figure 12: DDR Output Flip-Flop



Similarly, Figure 13 demonstrates the DDR input flip-flop functionality. A double data rate (DDR) signal arrives at the pad. Internally, one value is clocked by the rising edge of the INCLK signal and another value is clocked by the falling edge of the INCLK signal. The DDR data stream is effectively de-multiplexed within the PIO pin and presented to the programmable interconnect on D_IN_0 and D_IN_1.

Figure 13: DDR Input Flip-Flop



The DDR flip-flops provide several design advantages. Internally within the iCE65 device, the clock frequency is half the effective external data rate. The lower clock frequency eases internal timing, doubling the clock period, and slashes the clock-related power in half.

Automatic Global Buffer Insertion, Manual Insertion

The iCEcube development software automatically assigns high-fanout signals to a global buffer. However, to manual insert a global buffer input/global buffer (GBIN/GBUF) combination, use the `SB_IO_GB` primitive. To insert just a global buffer (GBUF), use the `SB_GB` primitive.

Global Hi-Z Control

The global high-impedance control signal, GHIZ, connects to all I/O pins on the iCE65 device. This GHIZ signal is automatically asserted throughout the configuration process, forcing all user-I/O pins into their high-impedance state. Similarly, the PIO pins can be forced into their high-impedance state via the JTAG controller.

Global Reset Control

The global reset control signal connects to all PLB and PIO flip-flops on the iCE65 device. The global reset signal is automatically asserted throughout the configuration process, forcing all flip-flops to their defined wake-up state. For PLB flip-flops, the wake-up state is always reset, regardless of the PLB flip-flop primitive used in the application. See Table 3 for more information.

The PIO flip-flops are always reset during configuration, although the output flip-flop can be inverted before leaving the iCE65 device, as shown in Figure 11.

RAM

Each iCE65 device includes multiple high-speed synchronous RAM blocks (RAM4K), each 4Kbit in size. As shown in Table 16 a single iCE65 integrates between 16 to 96 such blocks. Each RAM4K block is generically a 256-word deep by 16-bit wide, two-port register file, as illustrated in Figure 17. The input and output connections, to and from a RAM4K block, feed into the programmable interconnect resources.

Figure 17: RAM4K Memory Block

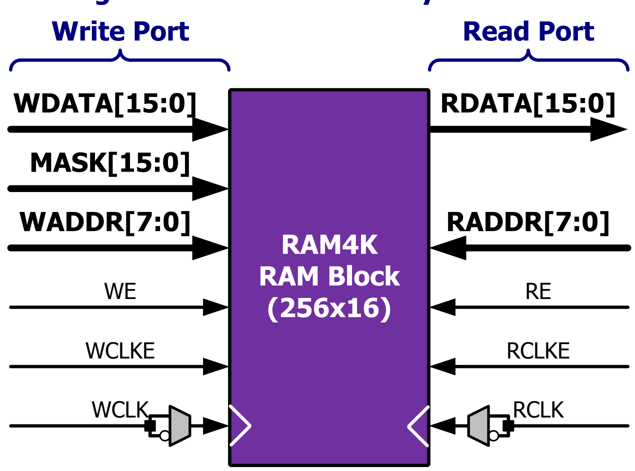


Table 16: RAM4K Blocks per Device

Device	RAM4K Blocks	Default Configuration	RAM Bits per Block	Block RAM Bits
iCE65L01	16	256 x 16	4K (4,096)	64K
iCE65L04	20			80K
iCE65L08	32			128K

Using programmable logic resources, a RAM4K block implements a variety of logic functions, each with configurable input and output data width.

- Random-access memory (RAM)
  - Single-port RAM with a common address, enable, and clock control lines
  - Two-port RAM with separate read and write control lines, address inputs, and enable

Table 31 describes how to maintain voltage compatibility for two interface scenarios. The easiest interface is when the Application Processor's (AP) I/O supply rail and the iCE65's SPI and VCCIO_2 bank supply rails all connect to the same voltage. The second scenario is when the AP's I/O supply voltage is greater than the iCE65's VCCIO_2 supply voltage.

***Table 31:* CRESET_B and CDONE Voltage Compatibility**

Condition	CRESET_B			CDONE Pull-up	Requirement
	Direct	**Open-Drain**	**Pull-up**		
VCCIO_AP = VCC_SPI **VCCIO_AP = VCCIO_2**	OK	OK with pull-up	Required if using open-drain output	Recommended	AP can directly drive CRESET_B High and Low although an open-drain output recommended is if multiple devices control CRESET_B. If using an open-drain driver, the CRESET_B input must include a 10 kΩ pull-up resistor to VCCIO_2. The 10 kΩ pull-up resistor to AP_VCCIO is also recommended.
AP_VCCIO > VCCIO_2	N/A	Required, requires pull-up	Required	Required	The AP must control CRESET_B with an open-drain output, which requires a 10 kΩ pull-up resistor to VCCIO_2. The 10 kΩ pull-up resistor to AP_VCCIO is required.

JTAG Boundary Scan Port

Overview

Each iCE65 device includes an IEEE 1149.1-compatible JTAG boundary-scan port. The port supports printed-circuit board (PCB) testing and debugging. It also provides an alternate means to configure the iCE65 device.

Signal Connections

The JTAG port connections are listed in Table 32.

***Table 32:* iCE65 JTAG Boundary Scan Signals**

Signal Name	Direction	Description
TDI	Input	Test Data Input. Must be tied off to GND when unused. (no pull-up resistor)*
TMS	Input	Test Mode Select. Must be tied off to GND when unused. (no pull-up resistor)*
TCK	Input	Test Clock. Must be tied off to GND when unused. (no pull-up resistor)*
TDO	Output	Test Data Output.
TRST_B	Input	Test Reset, active Low. Must be Low during normal device operation. Must be High to enable JTAG operations.*

* Must be tied off to GND or VCCIO_1, else VCCIO_1 draws current.

Table 33 lists the ball/pin numbers for the JTAG interface by package code. The JTAG interface is available in select package types. The JTAG port is located in I/O Bank 1 along the right edge of the iCE65 device and powered by the VCCIO_1 supply inputs. Consequently, the JTAG interface uses the associated I/O standards for I/O Bank 1.

***Table 33:* JTAG Interface Ball/Pin Numbers by Package**

JTAG Interface	VQ100	CB132	CB196	CB284
TDI	N/A	M12	M12	T16
TMS		P14	P14	V18
TCK		L12	L12	R16
TDO		N14	N14	U18
TRST_B		M14	M14	T18

Supported JTAG Commands

The JTAG interface supports the IEEE 1149.1 mandatory instructions, including EXTEST, SAMPLE/PRELOAD, and BYPASS.

Package and Pinout Information

Maximum User I/O Pins by Package and by I/O Bank

Table 34 lists the maximum number of user-programmable I/O pins by package, with additional detail showing user I/O pins by I/O bank. In some cases, a smaller iCE65 device is packaged in a larger package with unconnected (N.C.) pins or balls, resulting in fewer overall I/O pins. See Table 35 for device-specific I/O counts by package.

Table 34: **User I/O by Package, by I/O Bank**

	CB81	QN84	VQ100	CB132	CB196	CB284
Package Leads	81	84	100	132	196	284
Package Body (mm)	5 x 5	7 x 7	14 x 14	8 x 8	8 x 8	12 x 12
Ball Array (balls)	9 x 9	N/A	N/A	14 x 14	14 x 14	22 x 22
Ball/Lead Pitch (mm)	0.5	0.5	0.5	0.5	0.5	0.5
Maximum user I/O, all I/O banks	63	67	72	95	150	222
PIO Pins in Bank 0	17	17	19	26	37	60
PIO Pins in Bank 1	16	17	19	21	38	55
PIO Pins in Bank 2	12	11	12	20	35	53
PIO Pins in Bank 3	18	18	18	24	36	50
PIO Pins in SPI Interface	4	4	4	4	4	4

Printed Circuit Board Layout Information

For information on how to use the iCE65 packages on a printed circuit board (PCB) design, consult the following application note.

- AN010: iCE65 Printed Circuit Board (PCB Layout) Guidelines

Maximum User I/O by Device and Package

Table 35 lists the maximum available user I/O by device and by and package type. Not all devices are available in all packages. Similarly, smaller iCE65 devices may have unconnected balls in some packages. Devices sharing a common package have similar footprints.

Table 35: **Maximum User I/O by Device and Package**

Package	Device		
	iCE65L01	**iCE65L04**	**iCE65L08**
CB81	63	—	—
QN84	67	—	—
VQ100	72	72	
CB132	93	95	—
CB196	—	150	150
CB284	—	176	222

iCE65 Pin Descriptions

Table 36 lists the various iCE65 pins, alphabetically by name. The table indicates the directionality of the signal and the associated I/O bank. The table also indicates if the signal has an internal pull-up resistor enabled during configuration. Finally, the table describes the function of the pin.

Table 36: iCE65 Pin Description

Signal Name	Direction	I/O Bank	Pull-up during Config	Description
CDONE	Output	2	Yes	Configuration Done. Dedicated output. Includes a permanent weak pull-up resistor to VCCIO_2.. If driving external devices with CDONE output, connect a 10 kΩ pull-up resistor to VCCIO_2.
CRESET_B	Input	2	No	Configuration Reset, active Low. Dedicated input. No internal pull-up resistor. Either actively drive externally or connect a 10 kΩ pull-up resistor to VCCIO_2.
GBIN0/PIO0 **GBIN1/PIO0**	Input/IO	0	Yes	Global buffer input from I/O Bank 0. Optionally, a full-featured PIO pin.
GBIN2/PIO1 **GBIN3/PIO1**	Input/IO	1	Yes	Global buffer input from I/O Bank 1. Optionally, a full-featured PIO pin.
GBIN4/PIO2 **GBIN5/PIO2**	Input/IO	2	Yes	Global buffer input from I/O Bank 2. Optionally, a full-featured PIO pin.
GBIN6/PIO3	Input/IO	3	No	Global buffer input from I/O Bank 3. Optionally, a full-featured PIO pin.
GBIN7/PIO3	Input/IO	3	No	Global buffer input from I/O Bank 3. Optionally, a full-featured PIO pin. Optionally, a differential clock input using the associated differential input pin.
GND	Supply	All	N/A	Ground. All must be connected.
PIOx_yy	I/O	0,1,2	Yes	Programmable I/O pin defined by the iCE65 configuration bitstream. The 'x' number specifies the I/O bank number in which the I/O pin resides. The "yy' number specifies the I/O number in that bank.
PIO2/CBSEL0	Input/IO	2	Yes	Optional ColdBoot configuration SELect input, if ColdBoot mode is enabled. A full-featured PIO pin after configuration.
PIO2/CBSEL1	Input/IO	2	Yes	Optional ColdBoot configuration SELect input, if ColdBoot mode is enabled. A full-featured PIO pin after configuration.
PIO3_yy/ DPwwz	I/O	3	No	Programmable I/O pin that is also half of a differential I/O pair. Only available in I/O Bank 3. The "yy" number specifies the I/O number in that bank. The "ww" number indicates the differential I/O pair. The 'z' indicates the polarity of the pin in the differential pair. 'A'=negative input. 'B'=positive input.
PIOS/SPI_SO	I/O	SPI	Yes	SPI Serial Output. A full-featured PIO pin after configuration.
PIOS /SPI_SI	I/O	SPI	Yes	SPI Serial Input. A full-featured PIO pin after configuration.
PIOS / SPI_SS_B	I/O	SPI	Yes	SPI Slave Select. Active Low. Includes an internal weak pull-up resistor to SPI_VCC during configuration. During configuration, the logic level sampled on this pin determines the configuration mode used by the iCE65 device, as shown in Figure 20. An input when sampled at the start of configuration. An input when in SPI Peripheral configuration mode (SPI_SS_B = Low). An output when in SPI Flash configuration mode. A full-featured PIO pin after configuration.
PIOS/ SPI_SCK	I/O	SPI	Yes	SPI Slave Clock. An input when in SPI Peripheral configuration mode (SPI_SS_B = Low). An output when in SPI Flash configuration mode. A full-featured PIO pin after configuration.
TDI	Input	1	No	JTAG Test Data Input. If using the JTAG interface, use a 10kΩ pull-up resistor to VCCIO_1. Tie off to GND when unused.

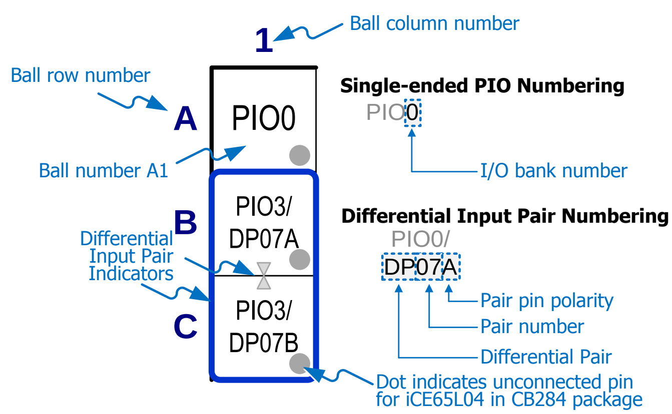
Signal Name	Direction	I/O Bank	Pull-up during Config	Description
TMS	Input	1	No	JTAG Test Mode Select. If using the JTAG interface, use a 10kΩ pull-up resistor to VCCIO_1. Tie off to GND when unused.
TCK	Input	1	No	JTAG Test Clock. If using the JTAG interface, use a 10kΩ pull-up resistor to VCCIO_1. Tie off to GND when unused.
TDO	Output	1	No	JTAG Test Data Output.
TRST_B	Input	1	No	JTAG Test Reset, active Low. Keep Low during normal operation; High for JTAG operation.
VCC	Supply	All	N/A	Internal core voltage supply. All must be connected.
VCCIO_0	Supply	0	N/A	Voltage supply to I/O Bank 0. All such pins or balls on the package must be connected. Can be disconnected or turned off without affecting the Power-On Reset (POR) circuit.
VCCIO_1	Supply	1	N/A	Voltage supply to I/O Bank 1. All such pins or balls on the package must be connected. Required to guarantee a valid input voltage on TRST_B JTAG pin.
VCCIO_2	Supply	2	N/A	Voltage supply to I/O Bank 2. All such pins or balls on the package must be connected. Required input to the Power-On Reset (POR) circuit.
VCCIO_3	Supply	3	N/A	Voltage supply to I/O Bank 3. All such pins or balls on the package must be connected. Can be disconnected or turned off without affecting the Power-On Reset (POR) circuit.
SPI_VCC	Supply	SPI	N/A	SPI interface voltage supply input. Must have a valid voltage even if configuring from NVCM. Required input to the Power-On Reset (POR) circuit.
VPP_FAST	Supply	All	N/A	Direct programming voltage supply. If unused, leave floating or unconnected during normal operation.
VPP_2V5	Supply	All	N/A	Programming supply voltage. When the iCE65 device is active, VPP_2V5 must be in the valid range between 2.3 V to 3.47 V to release the Power-On Reset circuit, even if the application is not using the NVCM.
VREF	Voltage Reference	3	N/A	Input reference voltage in I/O Bank 3 for the SSTL I/O standard. This pin only appears on the CB284 package and for die-based products.

N/A = Not Applicable

iCE65 Package Footprint Diagram Conventions

Figure 31 illustrates the naming conventions used in the following footprint diagrams. Each PIO pin is associated with an I/O Bank. PIO pins in I/O Bank 3 that support differential inputs are also numbered by differential input pair.

***Figure 31:* CB Package Footprint Diagram Conventions**



Ball Function	Ball Number	Pin Type	Bank
PIO2	B14	PIO	2
PIO2/CBSEL0	B15	PIO	2
PIO2/CBSEL1	A20	PIO	2
VCCIO_2	A17	PIO	2
GBIN6/PIO3	A9	GBIN	3
GBIN7/PIO3	A8	GBIN	3
PIO3	A1	PIO	3
PIO3	A2	PIO	3
PIO3	A3	PIO	3
PIO3	A4	PIO	3
PIO3	A5	PIO	3
PIO3	A10	PIO	3
PIO3	A11	PIO	3
PIO3	A12	PIO	3
PIO3	B1	PIO	3
PIO3	B2	PIO	3
PIO3	B3	PIO	3
PIO3	B4	PIO	3
PIO3	B5	PIO	3
PIO3	B7	PIO	3
PIO3	B8	PIO	3
PIO3	B9	PIO	3
VCCIO_3	B6	VCCIO	3
PIOS/SPI_SO	B17	SPI	SPI
PIOS/SPI_SI	A22	SPI	SPI
PIOS/SPI_SCK	A23	SPI	SPI
PIOS/SPI_SS_B	B18	SPI	SPI
SPI_VCC	A24	SPI	SPI
GND	A6	GND	GND
GND	A18	GND	GND
GND	A30	GND	GND
GND	B33	GND	GND
VCC	A7	VCC	VCC
VCC	A15	VCC	VCC
VCC	A28	VCC	VCC
VCC	B28	VCC	VCC
VPP_2V5	A36	VPP	VPP
VPP_FAST	A37	VPP	VPP

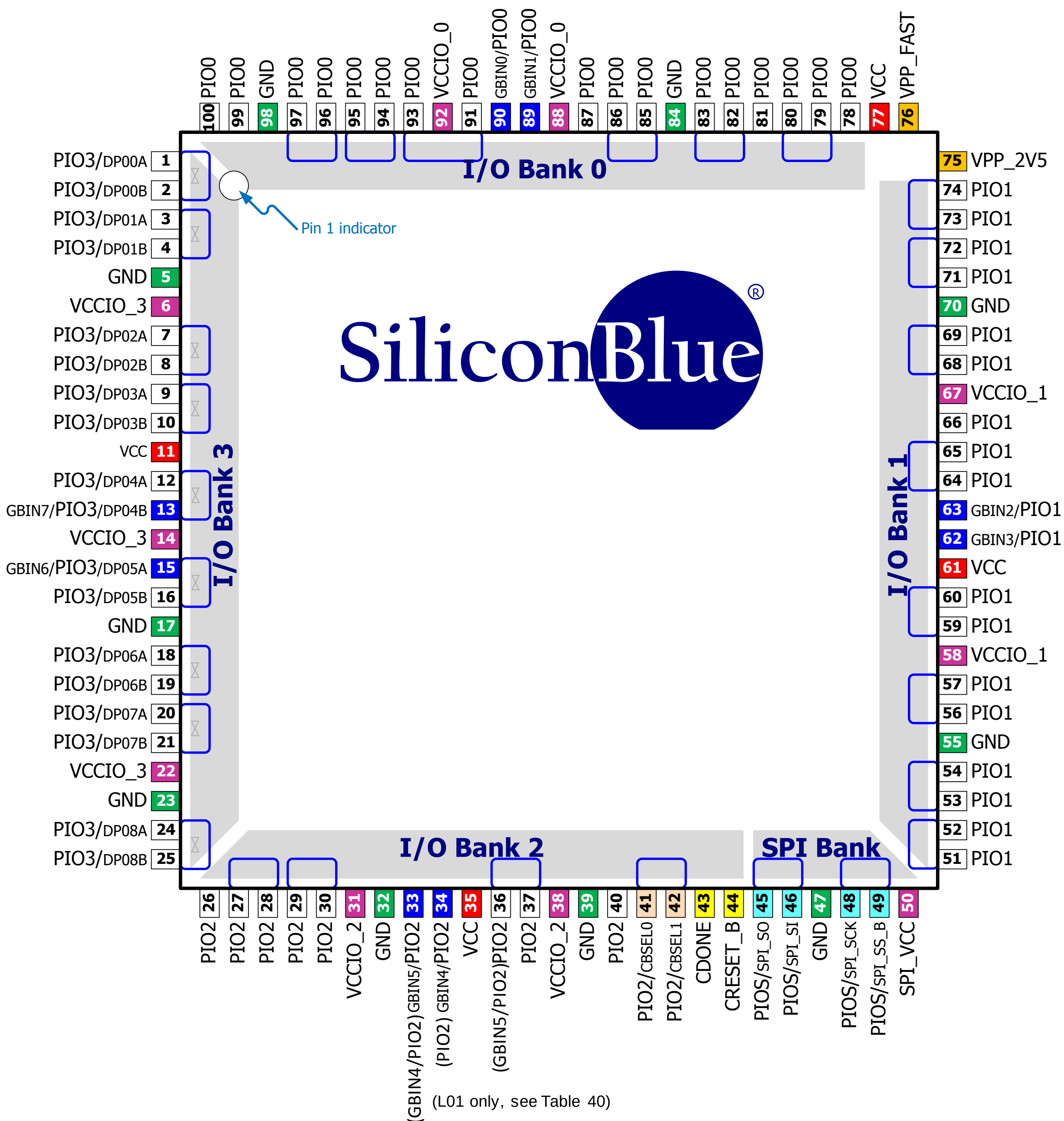
VQ100 Very-thin Quad Flat Package

The VQ100 package is a very-thin quad-flat package with 0.5 mm lead pitch. The iCE65L01 and iCE65L04 devices are available in this package.

Footprint Diagram

Figure 36 shows the footprint diagram for the 100-lead very-thin quad-flat package (VQ100). See Table 40 for a complete, detailed pinout for the 100-lead very-thin quad-flat package. The signal pins are also grouped into the four I/O Banks and the SPI interface.

Figure 36: iCE65 VQ100 Footprint (Top View)



Pinout Table

Table 39 provides a detailed pinout table for the VQ100 package. Pins are generally arranged by I/O bank, then by pin function. The table also highlights the differential I/O pairs in I/O Bank 3. The VQ100 package has no JTAG pins.

CB196 Chip-Scale Ball-Grid Array

The CB196 package is a chip-scale, fully-populated, ball-grid array with 0.5 mm ball pitch.

Footprint Diagram

Figure 45 shows the iCE65L04 chip-scale BGA footprint for the 8 x 8 mm CB196 package. The footprint for the iCE65L08 is different than the iCE64L04 footprint, as shown in Figure 46. The pinout differences are highlighted by warning diamonds (◆) in the footprint diagrams and summarized in Table 43.

> ⚠ Although both the iCE65L04 and iCE65L08 are both available in the CB196 package and ***almost*** completely pin compatible, there are differences as shown in Table 43.

Figure 31 shows the conventions used in the diagram. Also see Table 42 for a complete, detailed pinout for the 196-ball chip-scale BGA packages. The signal pins are also grouped into the four I/O Banks and the SPI interface.

Figure 45: iCE65L04 CB196 Chip-Scale BGA Footprint (Top View)

I/O Bank 0 (top) · I/O Bank 1 (right) · I/O Bank 2 (bottom, columns 1–10) · SPI Bank (bottom, columns 11–13) · I/O Bank 3 (left)

	1	2	3	4	5	6	7	8	9	10	11	12	13	14
A	PIO0	PIO0	PIO0	PIO0	PIO0	PIO0	GBIN0/ PIO0	VCCIO_0	GND	PIO0	PIO0	PIO0	VPP_ FAST	VPP_ 2V5
B	PIO3/ DP00B	PIO0	PIO0	PIO0	PIO0	PIO0	VCC	PIO0	PIO0	PIO0	PIO0	GND	PIO1	PIO1
C	PIO3/ DP00A	GND	PIO1/ DP01B	PIO0	PIO0	PIO0	PIO0	PIO0	PIO0	PIO0	PIO0	PIO1	PIO1	PIO1
D	PIO3/ DP02A	PIO3/ DP02B	PIO1/ DP01A	PIO3/ DP04A	PIO0	PIO0	PIO0	PIO0	PIO0	PIO0	PIO1	PIO1	PIO1	PIO1
E	PIO3/ DP03A ◆	PIO3/ DP03B ◆	VCCIO_3	PIO3/ DP04B	PIO3/ DP06B	PIO0	GBIN1/ PIO0	PIO0	PIO0	PIO1	PIO1	PIO1	PIO1	PIO1
F	GND	VCC	PIO3/ DP05A ◆	PIO3/ DP05B ◆	PIO3/ DP06A	VCCIO_0	GND	VCC	VCCIO_1	GBIN2/ PIO1	PIO1	PIO1	PIO1	PIO1
G	GBIN7/ PIO3/ DP07B ◇	PIO3/ DP07A ◆	PIO3/ DP09A	PIO3/ DP09B	PIO3/ DP13B	VCC	GND	GND	GND	PIO1	PIO1	GBIN3/ PIO1	PIO1	PIO1
H	GBIN6/ PIO3/ DP08A	PIO3/ DP08B	PIO3/ DP11B ◆	PIO3/ DP11A ◆	PIO3/ DP13A	GND	GND	GND	VCC	PIO1	PIO1	PIO1	PIO1	VCCIO_1
J	PIO3/ DP10A	PIO3/ DP10B	PIO3/ DP12B	VCC	GND	VCCIO_3	VCC	GND	VCCIO_2	PIO1	PIO1	PIO1	PIO1	GND
K	VCCIO_3	PIO3/ DP12A	PIO3/ DP16A ◆	PIO3/ DP16B ◆	PIO2	PIO2	PIO2	PIO2	PIO2	GND	PIO1	PIO1	VCC	PIO1
L	PIO3/ DP14A	PIO3/ DP14B	GND	PIO2	PIO2	PIO2	GBIN4/ PIO2 ◇	PIO2	PIO2/ CBSEL0	CRESET_B	SPI_ VCC	TCK	PIO1	PIO1
M	PIO3/ DP15A	PIO3/ DP15B	PIO2	PIO2	VCCIO_2	PIO2	PIO2 ◆	PIO2	PIO2	CDONE	PIOS/ SPI_SO	TDI	PIO1	TRST_B
N	PIO3/ DP17A	PIO3/ DP17B	PIO2	PIO2	PIO2	PIO2	VCC	PIO2 ◆	PIO2	VCCIO_2	PIO2	PIO2	PIO2	TDO
P	PIO2	PIO2	PIO2	PIO2	GBIN5/ PIO2 ◇	GND	PIO2	PIO2	PIO2	PIO2/ CBSEL1	PIOS/ SPI_SI	PIOS/ SPI_SCK	PIOS/ SPI_SS_B	TMS

Ball Function	Ball Number iCE65L04 iCE65L08	Pin Type by Device iCE65L04	iCE65L08	Bank	CB132 Ball Equivalent
PIO2	T13	PIO	PIO	2	M9
PIO2	V6	PIO	PIO	2	P2
PIO2	V7	PIO	PIO	2	P3
PIO2	V8	PIO	PIO	2	P4
PIO2	V9	PIO	PIO	2	P5
PIO2	V13	PIO	PIO	2	P9
PIO2	Y4	PIO	PIO	2	—
PIO2	Y5	PIO	PIO	2	—
PIO2	Y6	PIO	PIO	2	—
PIO2	Y7	PIO	PIO	2	—
PIO2	Y9	PIO	PIO	2	—
PIO2	Y10	PIO	PIO	2	—
PIO2	Y13	PIO	PIO	2	—
PIO2	Y14	PIO	PIO	2	—
PIO2	Y15	PIO	PIO	2	—
PIO2	Y17	PIO	PIO	2	—
PIO2	Y18	PIO	PIO	2	—
PIO2	Y19	PIO	PIO	2	—
PIO2	Y20	PIO	PIO	2	—
PIO2	AB2	PIO	PIO	2	—
PIO2 (●)	AB3	N.C.	PIO	2	—
PIO2 (●)	AB4	N.C.	PIO	2	—
PIO2	AB6	PIO	PIO	2	—
PIO2	AB7	PIO	PIO	2	—
PIO2	AB8	PIO	PIO	2	—
PIO2	AB9	PIO	PIO	2	—
PIO2	AB10	PIO	PIO	2	—
PIO2	AB11	PIO	PIO	2	—
PIO2	AB12	PIO	PIO	2	—
PIO2	AB13	PIO	PIO	2	—
PIO2	AB14	PIO	PIO	2	—
PIO2	AB15	PIO	PIO	2	—
PIO2 (●)	AB16	N.C.	PIO	2	—
PIO2 (●)	AB17	N.C.	PIO	2	—
PIO2 (●)	AB18	N.C.	PIO	2	—
PIO2 (●)	AB19	N.C.	PIO	2	—
PIO2 (●)	AB20	N.C.	PIO	2	—
PIO2 (●)	AB21	N.C.	PIO	2	—
PIO2 (●)	AB22	N.C.	PIO	2	—
PIO2/CBSEL0	R13	PIO	PIO	2	L9
PIO2/CBSEL1	V14	PIO	PIO	2	P10
VCCIO_2	N13	VCCIO	VCCIO	2	J9
VCCIO_2	T9	VCCIO	VCCIO	2	M5
VCCIO_2	Y11	VCCIO	VCCIO	2	—
PIO3/DP00A	F5	DPIO	DPIO	3	B1
PIO3/DP00B	G5	DPIO	DPIO	3	C1
PIO3/DP01A	G7	DPIO	DPIO	3	C3
PIO3/DP01B	H7	DPIO	DPIO	3	D3
PIO3/DP02A	H8	DPIO	DPIO	3	D4
PIO3/DP02B	J8	DPIO	DPIO	3	E4

Die Cross Reference

The tables in this section list all the pads on a specific die type and provide a cross reference on how a specific pad connects to a ball or pin in each of the available package offerings. Similarly, the tables provide the pad coordinates for the die-based version of the product (DiePlus). These tables also provide a way to prototype with one package option and then later move to a different package or die.

As described in "Input and Output Register Control per PIO Pair" on page 16, PIO pairs share register control inputs. Similarly, as described in "Differential Inputs and Outputs" on page 12, a PIO pair can form a differential input or output. PIO pairs in I/O Bank 3 are optionally differential inputs or differential outputs. PIO pairs in all other I/O Banks are optionally differential outputs. In the tables, differential pairs are surrounded by a heavy blue box.

iCE65L04

Table 45 lists all the pads on the iCE65L04 die and how these pads connect to the balls or pins in the supported package styles. Most VCC, VCCIO, and GND pads are double-bonded inside the package although the table shows only a single connection.

For additional information on the iCE65L04 DiePlus product, please refer to the following data sheet.

DiePlus Advantage FPGA Known Good Die

Table 45: iCE65L04 Die Cross Reference

iCE65L04 Pad Name	VQ100	CB132	CB196	CB284	DiePlus Pad	X (µm)	Y (µm)
PIO3_00/DP00A	1	B1	C1	F5	1	129.40	2,687.75
PIO3_01/DP00B	2	C1	B1	G5	2	231.40	2,642.74
PIO3_02/DP01A	3	C3	D3	G7	3	129.40	2,597.75
PIO3_03/DP01B	4	D3	C3	H7	4	231.40	2,552.74
GND	5	F1	F1	K5	5	129.40	2,507.75
GND	—	—	—	—	6	231.40	2,462.74
VCCIO_3	6	E3	E3	J7	7	129.40	2,417.75
VCCIO_3	—	—	—	—	8	231.40	2,372.74
PIO3_04/DP02A	7	D4	D1	H8	9	129.40	2,327.75
PIO3_05/DP02B	8	E4	D2	J8	10	231.40	2,292.74
PIO3_06/DP03A	—	D1	E1	H5	11	129.40	2,257.75
PIO3_07/DP03B	—	E1	E2	J5	12	231.40	2,222.74
VCC	—	—	H9	D3	13	129.40	2,187.75
PIO3_08/DP04A	9	F4	D4	K8	14	231.40	2,152.74
PIO3_09/DP04B	10	F3	E4	K7	15	129.40	2,117.75
PIO3_10/DP05A	—	—	F3	E3	16	231.40	2,082.74
PIO3_11/DP05B	—	—	F4	F3	17	129.40	2,047.75
GND	—	H6	A9	M10	18	231.40	2,012.74
PIO3_12/DP06A	—	—	F5	G3	19	129.40	1,977.75
PIO3_13/DP06B	—	—	E5	H3	20	231.40	1,942.74
GND	—	—	A9	J3	21	129.40	1,907.75
GND	—	—	—	—	22	231.40	1,872.74
PIO3_14/DP07A	—	—	—	H1	23	129.40	1,837.75
PIO3_15/DP07B	—	—	—	J1	24	231.40	1,802.74
VCCIO_3	—	—	K1	K3	25	129.40	1,767.75
VCC	11	G6	G6	L10	26	231.40	1,732.74
PIO3_16/DP08A	—	—	—	K1	27	129.40	1,697.75
PIO3_17/DP08B	—	—	—	L1	28	231.40	1,662.74

iCE65L08

Table 46 lists all the pads on the iCE65L08 die and how these pads connect to the balls or pins in the supported package styles. Most VCC, VCCIO, and GND pads are double-bonded inside the package although the table shows only a single connection.

For additional information on the iCE65L08 DiePlus product, please refer to the following data sheet.

- DiePlusAdvantage FPGA Known Good Die

Table 46: iCE65L08 Die Cross Reference

iCE65L08 Pad Name	Available Packages		DiePlus		
	CB196	CB284	Pad	X (µm)	Y (µm)
PIO3_00/DP00A	—	B1	1	129.735	3,882.665
PIO3_01/DP00B	—	C1	2	231.735	3,837.665
PIO3_02/DP01A	C1	F5	3	129.735	3,792.665
PIO3_03/DP01B	B1	G5	4	231.735	3,747.665
GND	C2	K5	5	129.735	3,702.665
GND	—	—	6	231.735	3,657.665
VCCIO_3	E3	J7	7	129.735	3,612.665
VCCIO_3	—	—	8	231.735	3,567.665
PIO3_04/DP02A	D3	E3	9	129.735	3,512.665
PIO3_05/DP02B	C3	F3	10	231.735	3,477.665
PIO3_06/DP03A	D1	G3	11	129.735	3,442.665
PIO3_07/DP03B	D2	H3	12	231.735	3,407.665
VCC	F2	D3	13	129.735	3,372.665
VCC	—	—	14	231.735	3,337.665
PIO3_08/DP04A	D4	D1	15	129.735	3,302.665
PIO3_09/DP04B	E4	E1	16	231.735	3,267.665
PIO3_10/DP05A	—	H1	17	129.735	3,232.665
PIO3_11/DP05B	—	J1	18	231.735	3,197.665
GND	F1	M10	19	129.735	3,162.665
GND	—	—	20	231.735	3,127.665
PIO3_12/DP06A	E2	H5	21	129.735	3,092.665
PIO3_13/DP06B	E1	J5	22	231.735	3,057.665
GND	L3	J3	23	129.735	3,022.665
GND	—	—	24	231.735	2,987.665
PIO3_14/DP07A	F5	K1	25	129.735	2,952.665
PIO3_15/DP07B	E5	L1	26	231.735	2,917.665
VCCIO_3	E3	K3	27	129.735	2,882.665
VCCIO_3	—	—	28	231.735	2,847.665
VCC	G6	L10	29	129.735	2,812.665
VCC	—	—	30	231.735	2,777.665
PIO3_16/DP08A	F4	G7	31	129.735	2,742.665
PIO3_17/DP08B	F3	H7	32	231.735	2,707.665
VCCIO_3	K1	F1	33	129.735	2,672.665
VCCIO_3	—	—	34	231.735	2,637.665
GND	—	G1	35	129.735	2,602.665
GND	—	—	36	231.735	2,567.665
PIO3_18/DP09A	G3	K8	37	129.735	2,532.665
PIO3_19/DP09B	G4	K7	38	231.735	2,497.665

I/O Characteristics

Table 49: PIO Pin Electrical Characteristics

Symbol	Description		Conditions	Minimum	Nominal	Maximum	Units
I_I	Input pin leakage current	I/O Bank 0, 1, 2	V_{IN} = $VCCIO_{max}$ to 0 V			±10	µA
		I/O Bank 3	V_{IN} = $VCCIO_{max}$				
I_{OZ}	Three-state I/O pin (Hi-Z) leakage current		V_O = $VCCIO_{max}$ to 0 V			±10	µA
C_{PIO}	PIO pin input capacitance				6		pF
C_{GBIN}	GBIN global buffer pin input capacitance				6		pF
R_{PULLUP}	Internal PIO pull-up resistance during configuration		VCCIO = 3.3V		40		kΩ
			VCCIO = 2.5V		50		kΩ
			VCCIO = 1.8V		90		kΩ
			VCCIO = 1.5V				kΩ
			VCCIO = 1.2V				kΩ
V_{HYST}	Input hysteresis		VCCIO = 1.5V to 3.3V		50		mV

NOTE: All characteristics are characterized and may or may not be tested on each pin on each device.

Single-ended I/O Characteristics

Table 50: I/O Characteristics (I/O Banks 0, 1, 2 and SPI only) (I/O Bank 3 iCE65L01 only)

I/O Standard	Nominal I/O Bank Supply Voltage	Input Voltage (V)		Output Voltage (V)		Output Current at Voltage (mA)	
		V_{IL}	V_{IH}	V_{OL}	V_{OH}	I_{OL}	I_{OH}
LVCMOS33	3.3V	0.80	2.00	0.4	2.40	8	8
LVCMOS25	2.5V	0.70	1.70	0.4	2.00	6	6
LVCMOS18	1.8V	35% VCCIO	65% VCCIO	0.4	1.40	4	4
LVCMOS15	1.5V	Not supported Use I/O Bank 3		0.4	1.20	2	2

Table 51: I/O Characteristics (I/O Bank 3 and iCE65L04/08 only)

I/O Standard	Supply Voltage	Input Voltage (V)		Output Voltage (V)		I/O Attribute Name	mA at Voltage
		Max. V_{IL}	Min. V_{IH}	Max. V_{OL}	Min. V_{OH}		I_{OL}, I_{OH}
LVCMOS33	3.3V	0.80	2.20	0.4	2.40	SL_LVCMOS33_8	±8
LVCMOS25	2.5V	0.70	1.70	0.4	2.00	SB_LVCMOS25_16	±16
						SB_LVCMOS25_12	±12
						SB_LVCMOS25_8 *	±8
						SB_LVCMOS25_4	±4
LVCMOS18	1.8V	35% VCCIO	65% VCCIO	0.4	VCCIO–0.45	SB_LVCMOS18_10	±10
						SB_LVCMOS18_8	±8
						SB_LVCMOS18_4 *	±4
						SB_LVCMOS18_2	±2
LVCMOS15	1.5V	35% VCCIO	65% VCCIO	25% VCCIO	75% VCCIO	SB_LVCMOS15_4	±4
						SB_LVCMOS15_2 *	±2
MDDR	1.8V	35% VCCIO	65% VCCIO	0.4	VCCIO–0.45	SB_MDDR10	±10
						SB_MDDR8	±8
						SB_MDDR4 *	±4
						SB_MDDR2	±2
SSTL2 (Class 2)	2.5V	VREF–0.180	VREF+0.180	0.35	VTT+0.430	SB_SSTL2_CLASS_2	±16.2
SSTL2 (Class 1)				0.54		SB_SSTL2_CLASS_1	±8.1
SSTL18 (Full)	1.8V	VREF–0.125	VREF+0.125	0.28	VTT+0.280	SB_SSTL18_FULL	±13.4
SSTL18 (Half)				VTT–0.475	VTT+0.475	SB_SSTL18_HALF	±6.7

NOTES:
SSTL2 and SSTL18 I/O standards require the VREF input pin, which is only available on the CB284 package and die-based products.

RAM4K Block

Table 56 provides timing information for the logic in a RAM4K block, which includes the paths shown in Figure 59.

Figure 59: RAM4K Timing Circuit

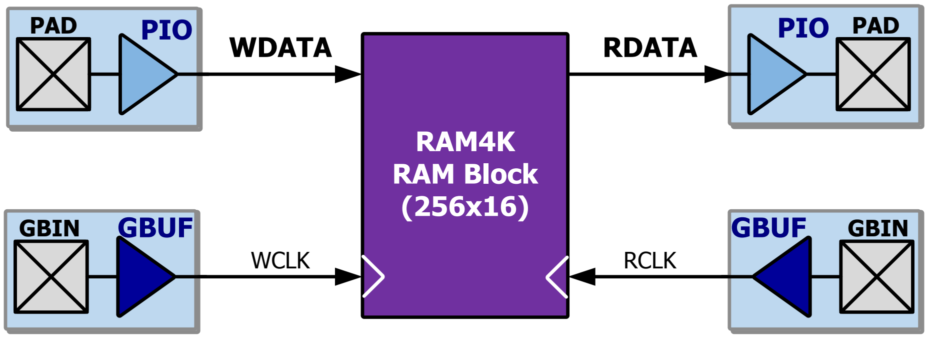


Table 56: Typical RAM4K Block Timing

Symbol	From	To	Description	L01	L04, L08			Units
			Device: iCE65	L01	L04, L08			
			Power/Speed Grade	–T	–L	–L	–T	
			Nominal VCC	1.2 V	1.0 V	1.2 V	1.2 V	
				Typ.	Typ.	Typ.	Typ.	
Write Setup/Hold Time								
t_{SUWD}	PIO input	GBIN input	Minimum write data setup time on PIO inputs before active clock edge on GBIN input, include interconnect delay.	0.6	3.1	1.7	0.8	ns
t_{HDWD}	GBIN input	PIO input	Minimum write data hold time on PIO inputs after active clock edge on GBIN input, including interconnect delay.	0	0	0	0	ns
Read Clock-Output-Time								
t_{CKORD}	RCLK clock input	PIO output	Clock-to-output delay from RCLK input pin, through RAM4K RDATA output flip-flop to PIO output pad, including interconnect delay.	5.6	17.1	9.1	7.3	ns
t_{GBCKRM}	GBIN input	RCLK clock input	Global Buffer Input (GBIN) delay, though Global Buffer (GBUF) clock network to the RCLK clock input.	2.1	7.3	3.8	2.6	ns
Write and Read Clock Characteristics								
t_{RMWCKH}	WCLK RCLK	WCLK RCLK	Write clock High time	0.54	1.14	0.54	0.54	ns
t_{RMWCKL}			Write clock Low time	0.63	1.32	0.63	0.63	ns
t_{RMWCYC}			Write clock cycle time	1.27	2.64	1.27	1.27	ns
F_{WMAX}			Sustained write clock frequency	256	256	256	256	MHz

Revision History

Version	Date	Description
2.42	30-MAR-2012	Changed company name. Updated Table 1
2.41	1-AUG-2011	Added VQ100 marking for NVCM programming.
2.4	13-MAY-2011	Added L01 CB121 package Figure 39. Added note "else VCCIO_1 draws current" to JTAG inputs TCK, TDI and TMS do not have the input pull-up resistor and must be tied off to GND when unused, Table 32. Input pin leakage current Table 49 split by bank. QN84 package drawing, Figure 35, added note "underside metal is at ground potential", increased thermal resistance. Added Marking Format and Thermal resistance to CB81 Packag Mechanical Drawing Figure 33. Added coplanarity specification to VQ100 Package Mechanical Drawing Figure 37
2.3	18-OCT-2010	Added L01 CB81 and L08 CB132 packages.
2.2.3	12-OCT-2010	Changed Figure 29: Application Processor Waveforms for SPI Peripheral Mode Configuration Process and Table 60 from 300 µs CRESET_B to 800 µs for iCE65L01/04 and 1200 µs for iCE65L08.
2.2.2	8-OCT-2010	Added iCE65L04 marking specification to Figure 47 CB196 Package Mechanical Drawing.
2.2.1	5-OCT-2010	Changed FSPI_SCK from 0.125 MHz to 1 MHz in SPI Peripheral Configuration Interface and in Table 60.
2.2	6-AUG-2010	Programmable Interconnect section removed.
2.1.1	26-MAY-2010	Switched labels on Figure 53 LVCMOS Output High, VCCIO = 1.8V with VCCIO = 2.5V.
2.1	15-MAR-2010	Added JTAG unused input tie off guideline. Added marking specification and thermal characteristics to package drawings. Added production datasheet for iCE65L01 with timing update, including QN84, VQ100 and CB132. Added NVCM shut-off on SPI configuration. Added non-standard VCCIO operating conditions. Increased the minimum voltage supply specification for LVCMOS33 to 3.14V in Table 48.
2.0.1	12-NOV-2009	Recommended Operation Conditions, Table 47, replaced junction with ambient.
2.0	14-SEPT-2009	Finalized production data sheet for iCE65L04 and iCE65L08. Improved SubLVDS input specification V_{ICM} in Table 52. CS63 and CC72 packages removed and placed in iCE DiCE KGD, Known Good Die datasheet. Added "IBIS Models for I/O Banks 0, 1, 2 and the SPI Bank". Added "Printed Circuit Board Layout Information".
1.5.1	13-JUL-2009	Updated the text in "SPI PROM Requirements" section. Minor label change in Figure 48.
1.5	20-JUN-2009	Updated timing information and added –T high-speed device option (affected Figure 2, Table 48, Table 54, Table 55, Table 56, and Table 61). Added support for 3.3V LVCMOS I/Os in I/O Bank 3 (affected Figure 7, Table 5, Table 7, Table 8, Table 47, Table 48, and Table 51). Added a section about the SPI Peripheral Configuration Interface and timing in Table 60. Added a warning that a Warm Boot operation can only jump to another configuration image that has Warm Boot disabled. Updated configuration image size and configuration time for the iCE65L02 in Table 27 and Table 58. Reduced the minimum voltage supply specification for LVCMOS33 to 2.7V in Table 48. Added information about which power rails can be disconnected without effecting the Power-On Reset (POR) circuit and clarified description of VPP_2V5 pin in Table 36. Added I/O characterization curves (Figure 52, Figure 53, and Figure 54). Minor changes to Figure 20 and Figure 21. Changed timing per Figures 54-58 and Tables 55-57.
1.4.4	25-MAR-2009	Clarified the voltage requirements for the VPP_2V5 pin in Table 36 and notes under Table 48.
1.4.3	9-MAR-2009	Removed volatile-only (-V) product offering from Figure 2. Corrected NC on ball V22, removed it for ball T22 on CB284 package (Figure 48).
1.4.2	27-FEB-2009	Updated Table 14, Table 23, Table 26, Table 30, Table 33, Table 35, and Table 46. Updated I/O Bank 3 information in Table 7 and Table 48.
1.4.1	24-FEB-2009	Based on characterization data, reduced 32KHz operating current by 40% in Table 1, Table 61, and Figure 1. Corrected that SSTL18 standards require VREF pin in Table 7. Correct ball numbers for GBIN4/GBIN5 for CS110 package.
1.4	9-FEB-2009	Added footprint and pinout information for the VQ100 Very-thin Quad Flat Package. Added footprint for iCE65L08 in CB196 (Figure 46) and added Table 43 showing the differences between the 'L04 and 'L08 in the CB196 package. Unified the package footprint nomenclature in the Package and Pinout Information section. Added note to Global Buffer Inputs that the differential clock direct input is not available on the CB132 package. Added tables showing the ball/pin number for various control functions, by package (Table 14, Table 23, Table 26, Table 30, and Table 33). Corrected the GBIN/GBUF designations. GBIN4 and GBIN5 were swapped as were GBIN6 and GBIN7. This change affected all pinout tables and footprint diagrams. Updated and corrected "Differential Global Buffer Input." Tested and corrected the clock-enable and reset connections between global buffers and various resources (Table 11, Table 12, and Table 13). Added "Automatic Global Buffer Insertion, Manual Insertion." Added "Die Cross Reference" section. Improved industrial temperature range by lowering

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